Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/810,145	MURAKAMI ET AL.	
Examiner	Art Unit	
Brian E. Miller	2652	

SEARCHED			
	JEAR	CHED	т
Class	Subclass	Date	Examiner
360	244.2		
360	244.9		
360	245		
360	245.3		
360	245.4		
360	245.5	.	
360	245.7	8/19/2005	вем
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

(INCLUDING SEAR	CH STRATEGY	<u>') </u>
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reviewed parent-09/673,919	8/19/2005	ВЕМ
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